

N-Ch MOSFET

General Description

The WSP10N10 is the highest performance trench N-Ch MOSFET with extreme high cell density, which provide excellent RDSON and gate charge for most of the synchronous buck converter applications.

The WSF08N10 meet the RoHS and Green Product requirement, 100% EAS guaranteed with full function reliability approved.

Features

- Advanced high cell density Trench technology
- Super Low Gate Charge
- Excellent Cdv/dt effect decline
- Green Device Available

Product Summery

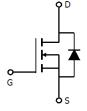
BVDSS	RDSON	ID
100V	22mΩ	10A

Applications

• Power Management in DC/DC Converter.

SOP-8 Pin Configuration





Absolute Maximum Ratings

Symbol	Parameter	Rating	Units
V_{DS}	Drain-Source Voltage	100	V
V_{GS}	Gate-Source Voltage	±20	V
I _D @T _C =25℃	Continuous Drain Current, V _{GS} @ 10V ¹	10	А
I _D @T _C =70°C	Continuous Drain Current, V _{GS} @ 10V ¹	8.2	Α
I _{DM}	Pulsed Drain Current ²	60	А
EAS	Single Pulse Avalanche Energy ³	42	mJ
I _{AS}	Avalanche Current	30	А
P _D @T _A =25°C	Total Power Dissipation ⁴	3.1	W
T _{STG}	Storage Temperature Range	-55 to 150	°C
TJ	Operating Junction Temperature Range -55 to 150		$^{\circ}\!$

Thermal Data

Symbol	Parameter	Тур.	Max.	Unit
$R_{ heta JA}$	Thermal Resistance Junction-ambient ¹		40	°C/W
$R_{ heta JC}$	Thermal Resistance Junction-Case ¹		24	°C/W



Electrical Characteristics (T_J=25 ℃, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit	
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =250uA	100			V	
$\triangle BV_{DSS}/\triangle T_{J}$	BVDSS Temperature Coefficient	Reference to 25°C , I _D =1mA		0.098		V/℃	
В	Static Drain-Source On-Resistance ²	V _{GS} =10V , I _D =10A		22	28	mΩ	
$R_{DS(ON)}$		V _{GS} =4.5V , I _D =6.5A		25	31		
$V_{GS(th)}$	Gate Threshold Voltage	V _{GS} =V _{DS} , I _D =250uA	1.5	2.0	2.5	V	
$\triangle V_{GS(th)}$	V _{GS(th)} Temperature Coefficient	V _{GS} -V _{DS} , I _D -230uA		-5.52		mV/℃	
	Drain-Source Leakage Current	V _{DS} =80V , V _{GS} =0V , T _J =25°C	V_{DS} =80V , V_{GS} =0V , T_{J} =25 $^{\circ}$ C			10	
I _{DSS}	Dialii-Source Leakage Current	V_{DS} =80V , V_{GS} =0V , T_J =55 $^{\circ}$ C		100 uA	uA		
I _{GSS}	Gate-Source Leakage Current	V_{GS} = $\pm 20V$, V_{DS} = $0V$			±100	nA	
Rg	Gate Resistance	V _{DS} =0V , V _{GS} =0V , f=1MHz		0.65	1.0	Ω	
Qg	Total Gate Charge (10V)			28			
Q_gs	Gate-Source Charge	V _{DS} =80V , V _{GS} =10V , I _D =10A		9		nC	
Q_gd	Gate-Drain Charge			10			
$T_{d(on)}$	Turn-On Delay Time			12			
Tr	Rise Time	V_{DD} =30V , V_{GEN} =10V , R_{G} =6 Ω		4		no	
$T_{d(off)}$	Turn-Off Delay Time	I _D =1A ,R _L =30Ω		17		ns	
T _f	Fall Time			5			
Ciss	Input Capacitance	V _{DS} =30V , V _{GS} =0V , f=1MHz		1769			
Coss	Output Capacitance			164		pF	
C _{rss}	Reverse Transfer Capacitance			53]	

Guaranteed Avalanche Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
EAS	Single Pulse Avalanche Energy ⁵	V _{DD} =25V , L=0.3mH , I _{AS} =10A	30			mJ

Diode Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Is	Continuous Source Current ^{1,6}	V_G = V_D = $0V$, Force Current			5	Α
I _{SM}	Pulsed Source Current ^{2,6}				30	Α
V_{SD}	Diode Forward Voltage ²	V_{GS} =0V , I_S =6A , T_J =25 $^{\circ}$ C			1.1	V
t _{rr}	Reverse Recovery Time	IF=10A , dl/dt=100A/μs , T J=25℃		27		nS
Q _{rr}	Reverse Recovery Charge			28		nC

Note

- 1.The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper,t<10sec.
- 2. The data tested by pulsed , pulse width $\leq 300 \text{us}$, duty cycle $\leq 2\%$
- 3. The EAS data shows Max. rating . The test condition is V_{DD} =25V, V_{GS} =10V,L=0.3mH, I_{AS} =10A
- 4.The power dissipation is limited by 150 $^{\circ}\mathrm{C}$ junction temperature
- 5. The Min. value is 100% EAS tested guarantee.
- 6. The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.

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Typical Characteristics

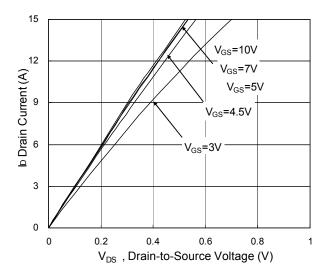


Fig.1 Typical Output Characteristics

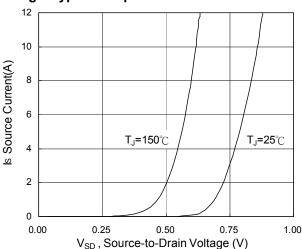


Fig.3 Forward Characteristics Of Reverse

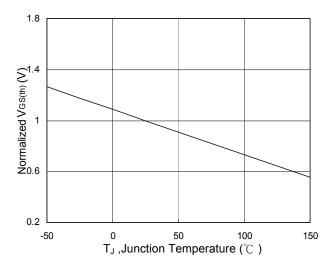


Fig.5 Normalized $V_{GS(th)}$ vs. T_J

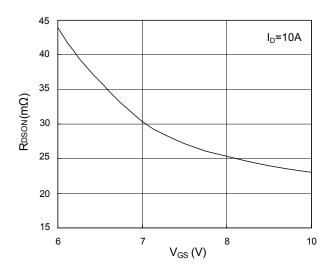


Fig.2 On-Resistance vs. Gate-Source

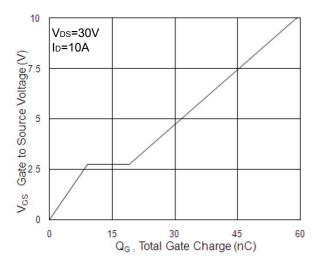


Fig.4 Gate-Charge Characteristics

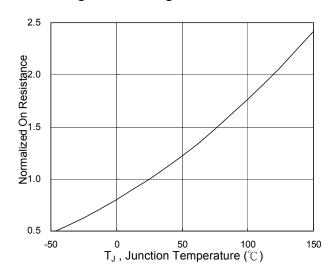
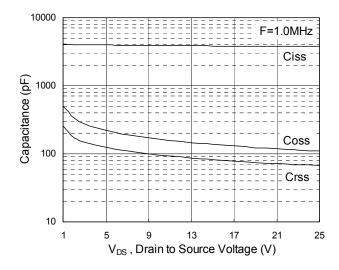


Fig.6 Normalized R_{DSON} vs. T_J





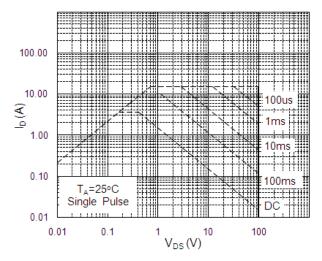


Fig.7 Capacitance

Fig.8 Safe Operating Area

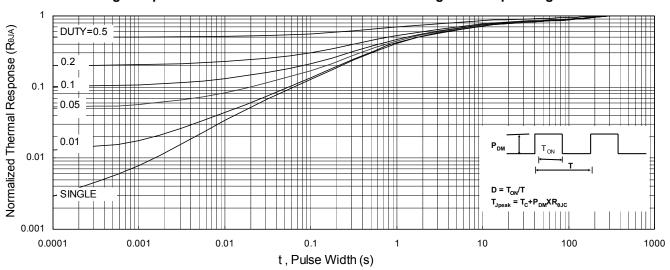


Fig.9 Normalized Maximum Transient Thermal Impedance

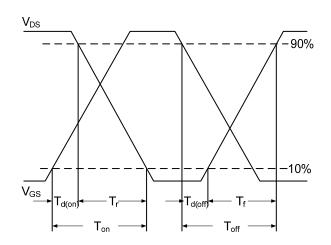


Fig.10 Switching Time Waveform

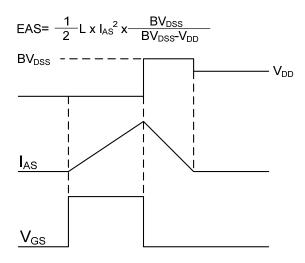


Fig.11 Unclamped Inductive Switching Waveform



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